

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	09652150	HOSHINO ET AL.
	<b>Examiner</b> Hernández, Nelson D	<b>Art Unit</b> 2622

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	370, 340, 373, 374, 294, 335, 371, 65	2/2/08	
438	121	2/2/08	
257	730, 684, 719, 708, 709, 711, 700	2/2/08	
359	808	2/2/08	

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted Lin Ye about claim limitations and allowable subject matter	1/30/08	NDHH
EAST text search for related art	2/1/08	NDHH
IEEE and SPIE for related art	2/2/08	NDHH
sholar.google.com for related art	2/2/08	NDHH
Inventor search for related art and DP	2/2/08	NDHH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	US-PAT and US-PGPUBS databases in EASTfor interference	2/2/08	NDHH